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(12) **United States Design Patent**
Ihara

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(54) **INFRARED MICROSCOPE**

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(30) **Foreign Application Priority Data**

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(51) **LOC (11) Cl.** **16-06**

(52) **U.S. Cl.**
USPC **D16/131**

(58) **Field of Classification Search**
USPC D18/50; D24/216; D14/125; D10/75,
D10/81; D16/130-136, 225
CPC .. G02B 21/008; G02B 21/0088; G02B 21/20;
G02B 21/22; G02B 21/24
See application file for complete search history.

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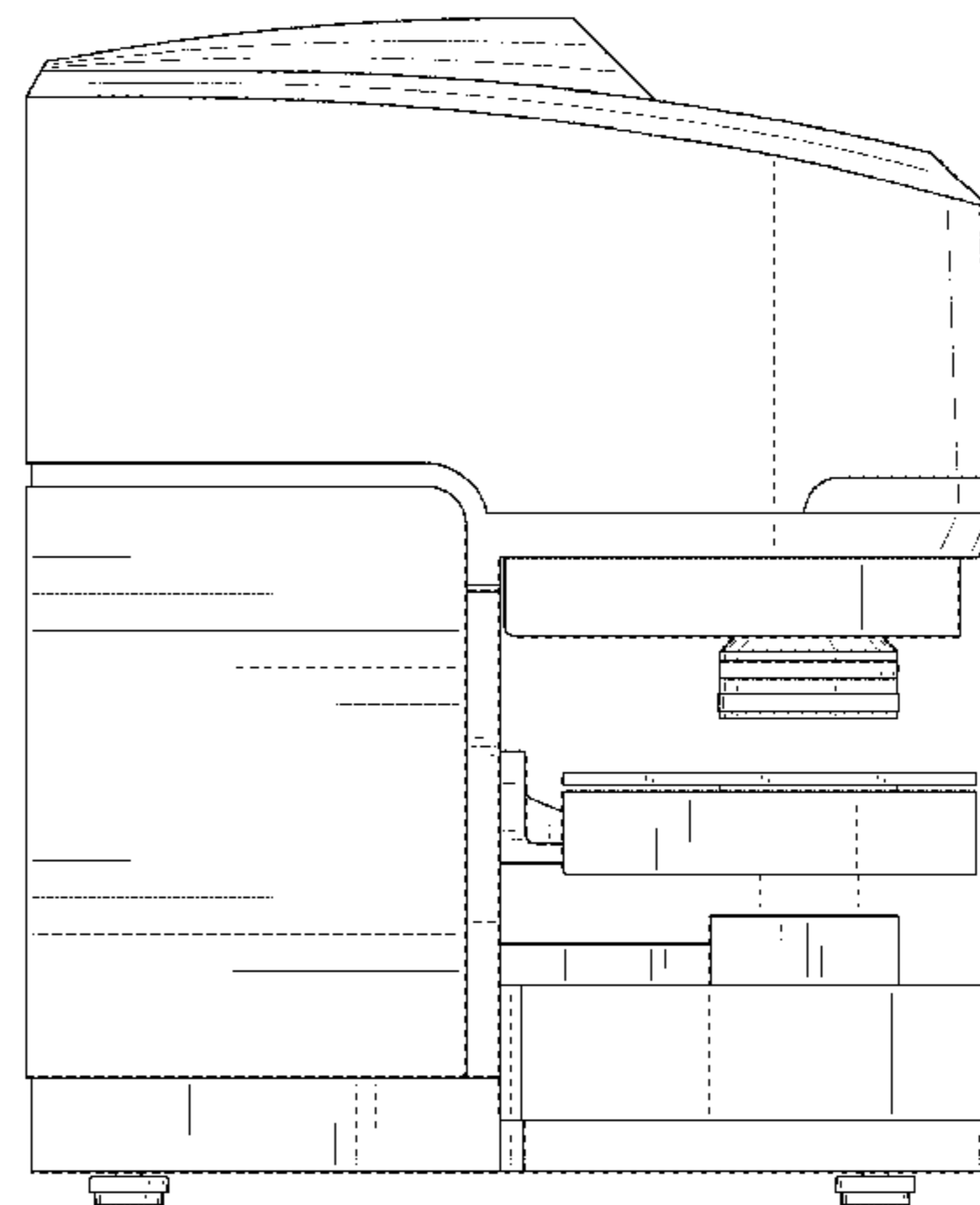
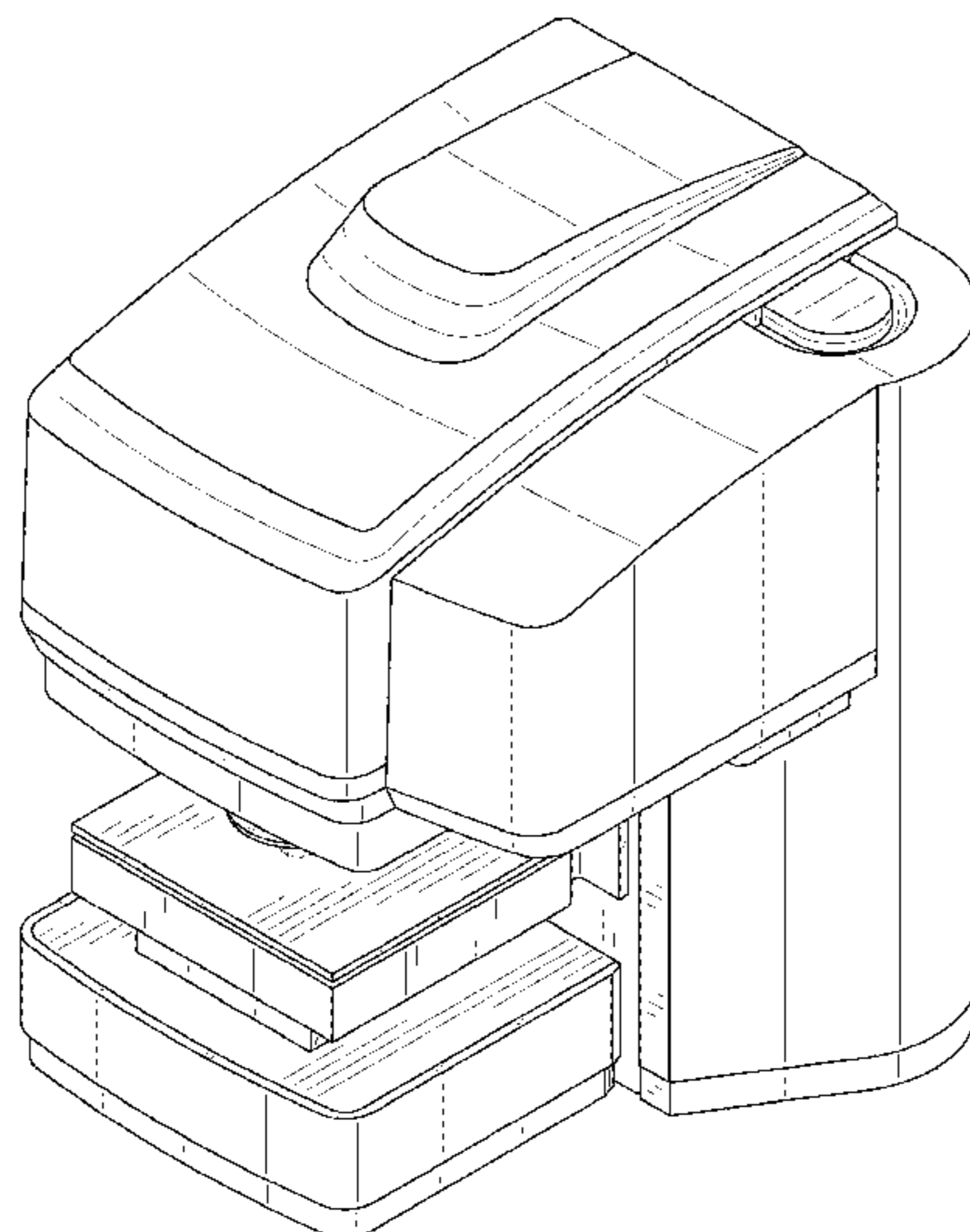
(57) **CLAIM**

The ornamental design for an infrared microscope, as shown and described.

DESCRIPTION

FIG. 1 is a perspective view of an infrared microscope showing my new design;
FIG. 2 is another perspective view thereof;
FIG. 3 is a front view thereof;
FIG. 4 is a rear view thereof;
FIG. 5 is a left side view thereof;
FIG. 6 is a right side view thereof;
FIG. 7 is a top view thereof; and
FIG. 8 is a bottom view thereof;
FIG. 9 is a cross-section view thereof, taken along the line 9-9 of FIG. 3;
FIG. 10 is a cross-section view thereof, taken along the line 10-10 of FIG. 3; and,
FIG. 11 is a cross-section view thereof, taken along the line 11-11 of FIG. 3.
The broken lines depict portions of the infrared microscope and form no part of the claimed design.

1 Claim, 11 Drawing Sheets



(56)

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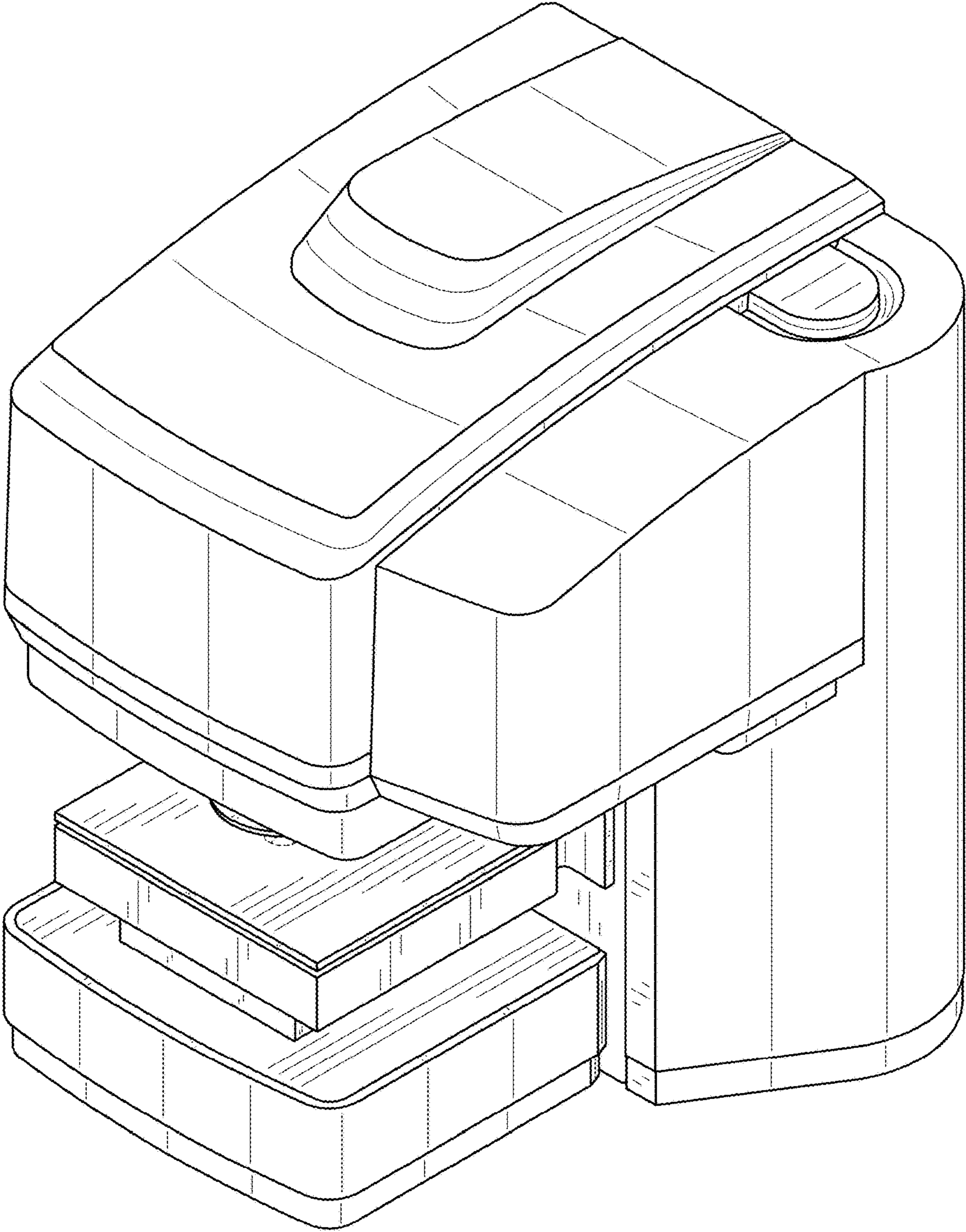


FIG. 1

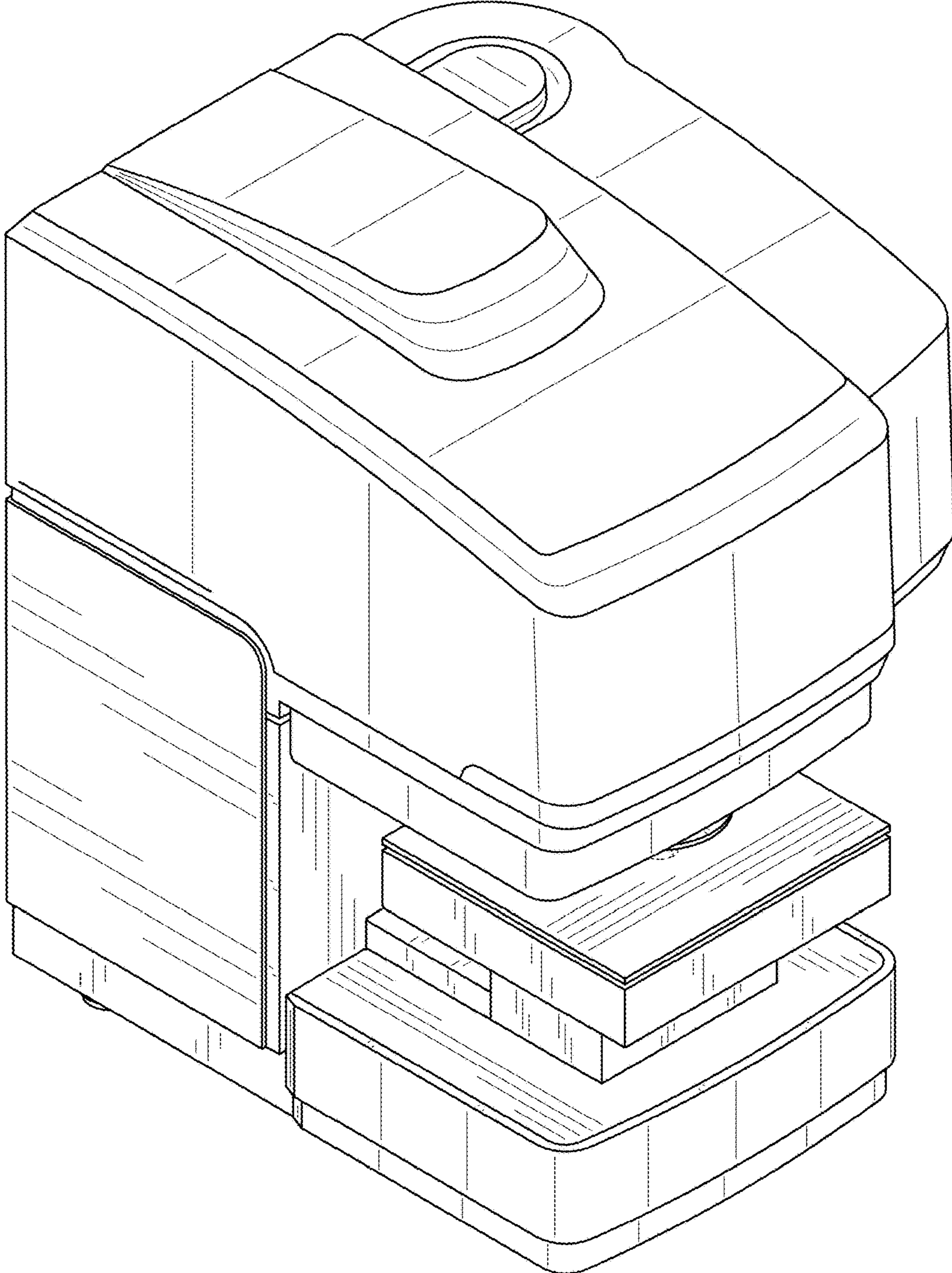


FIG. 2

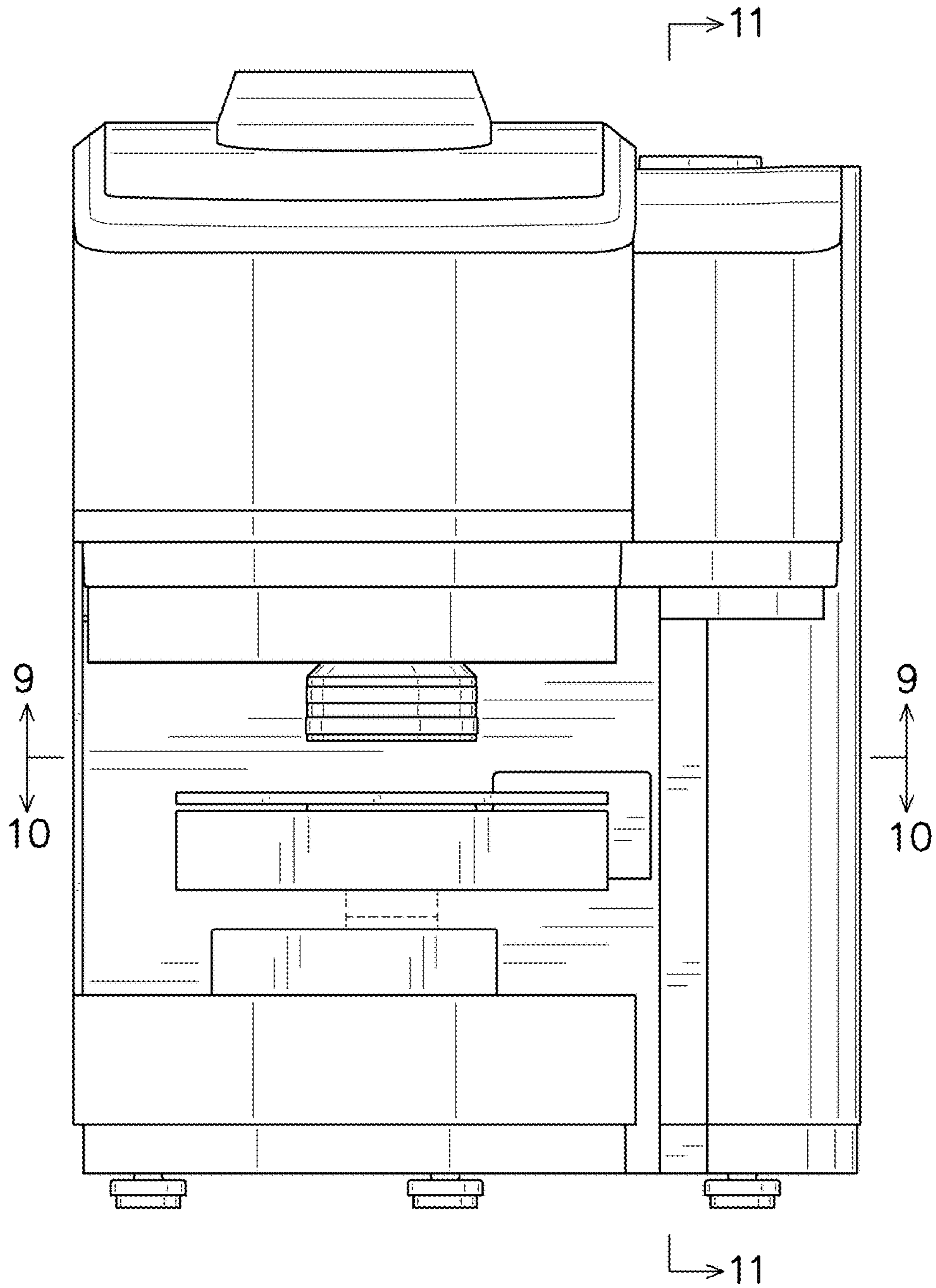


FIG. 3

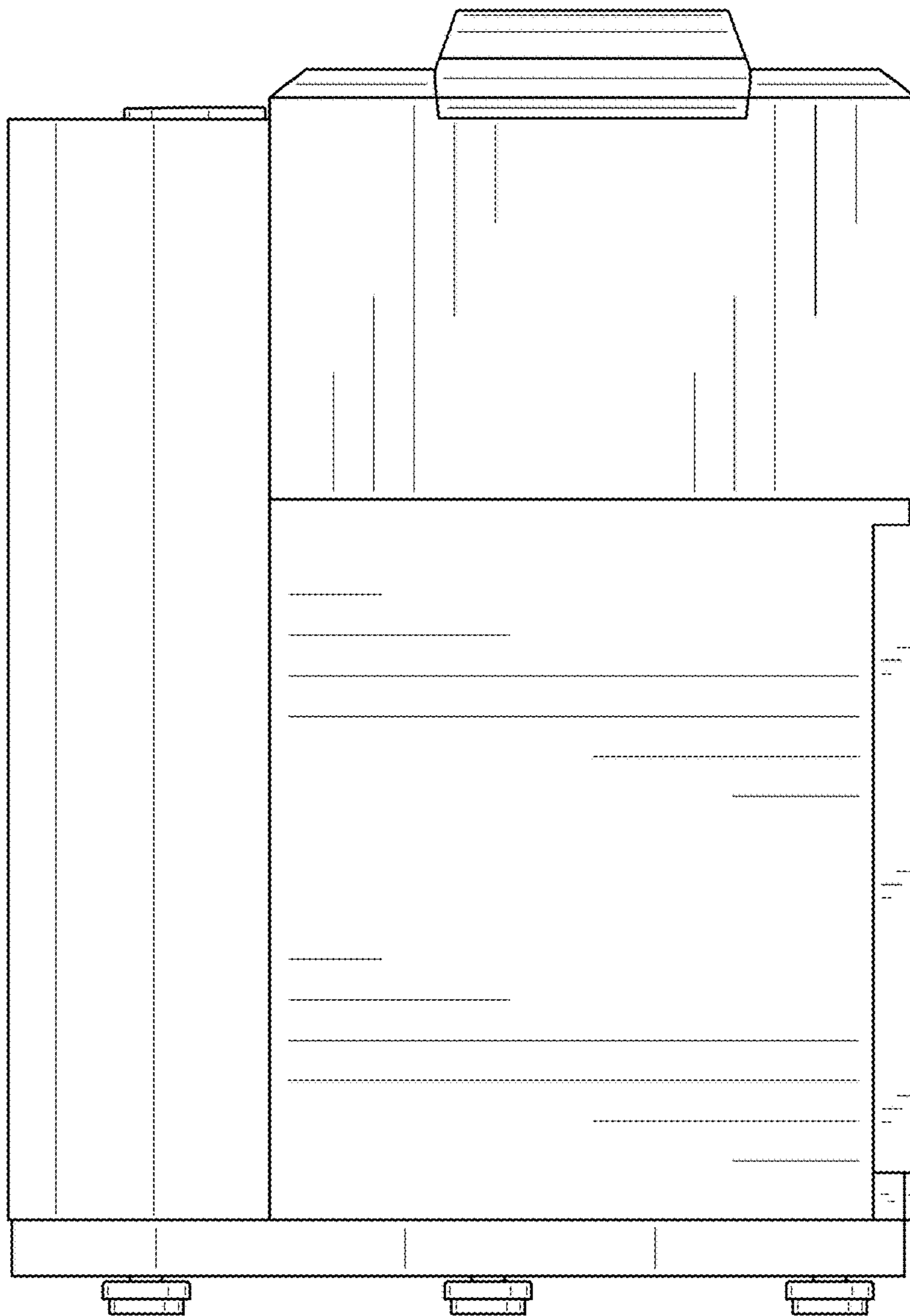


FIG. 4

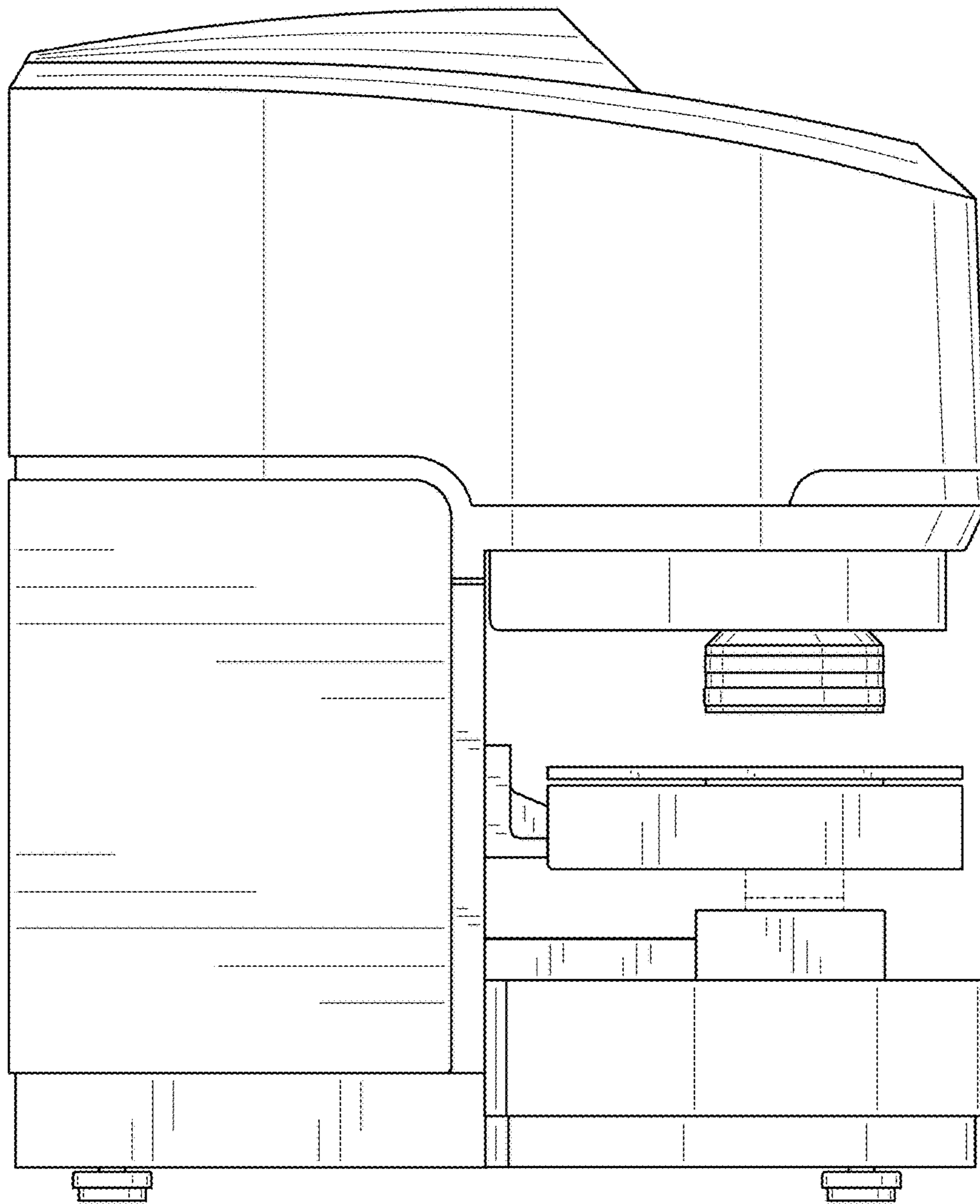


FIG. 5

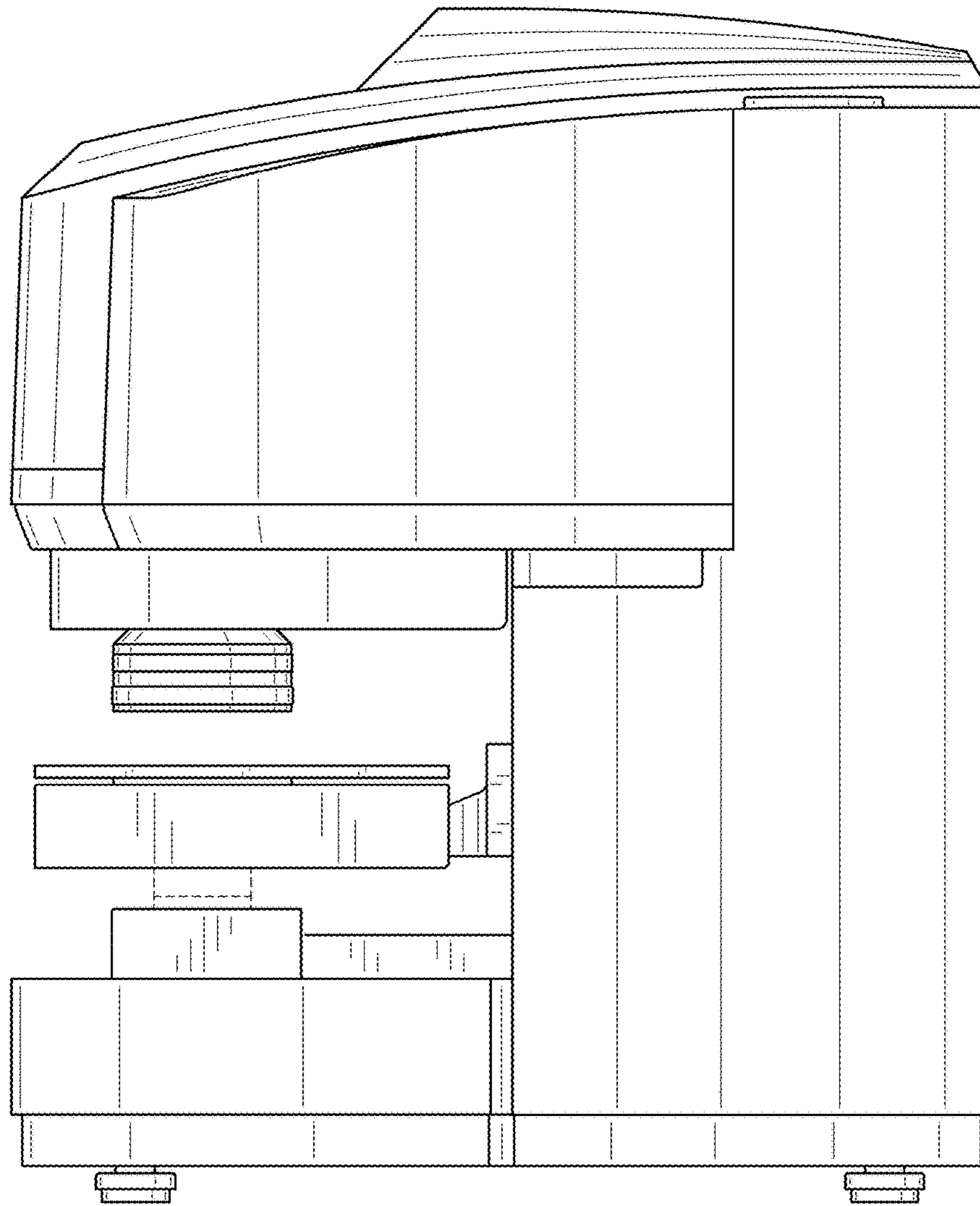


FIG. 6

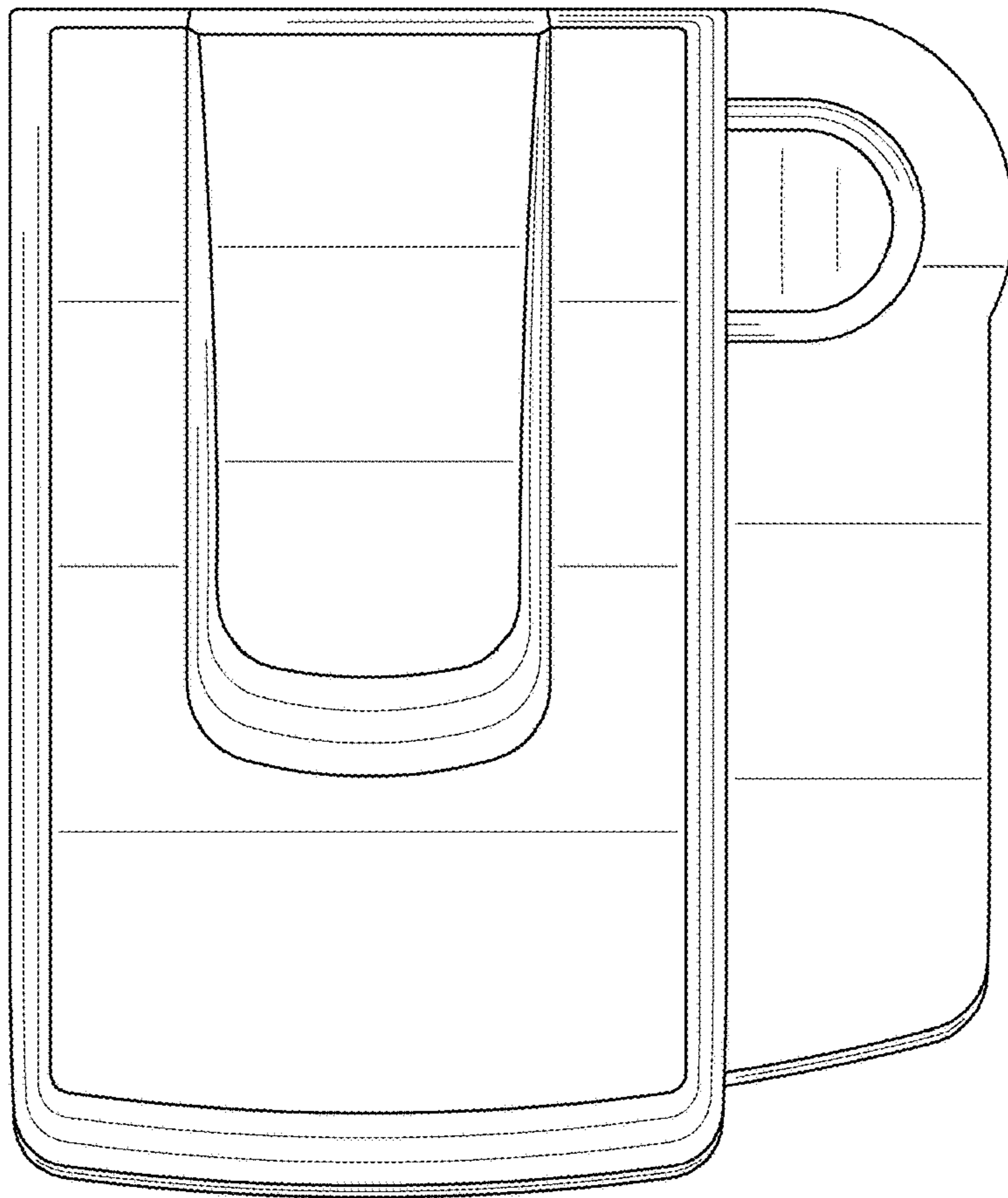


FIG. 7

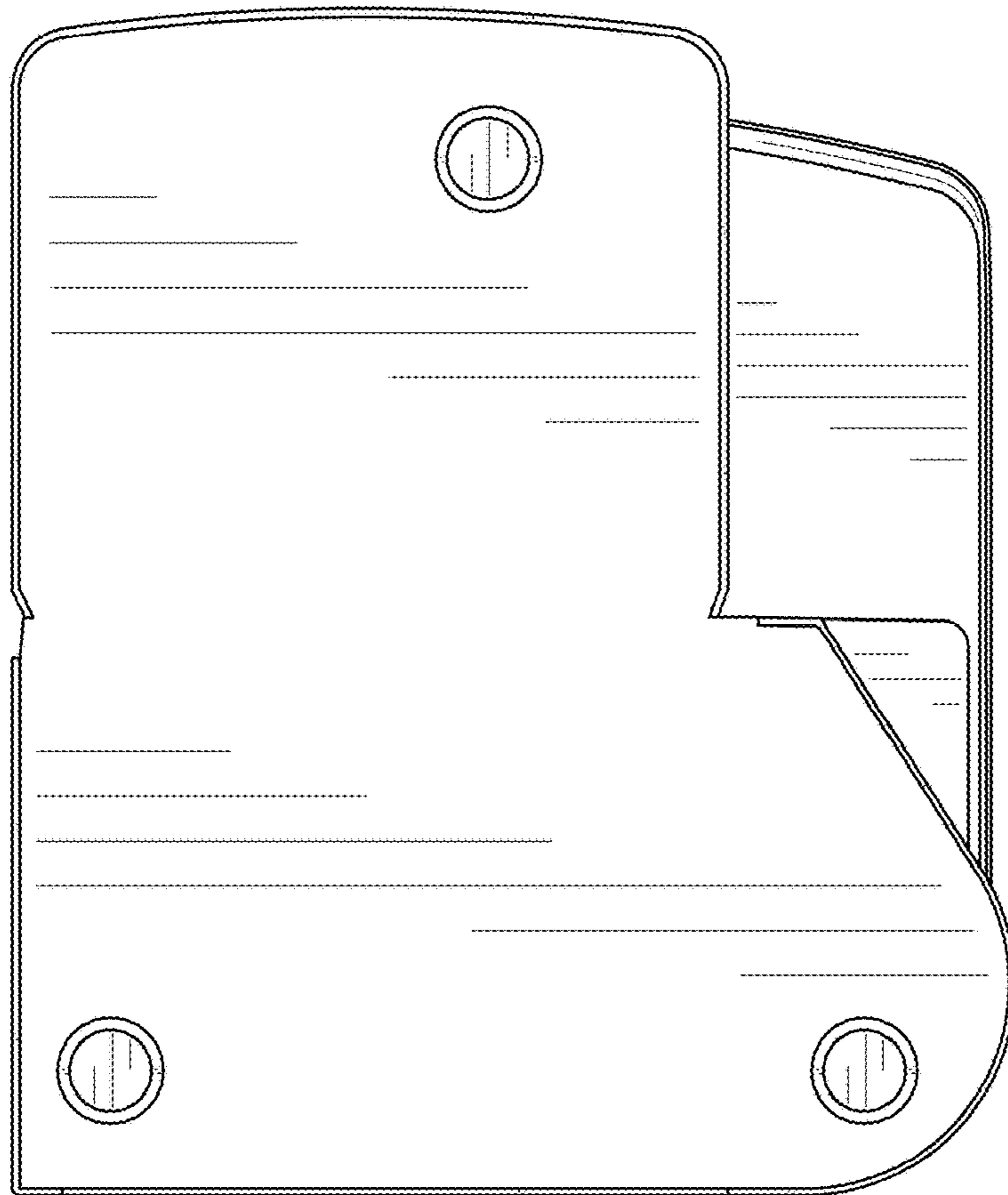


FIG. 8

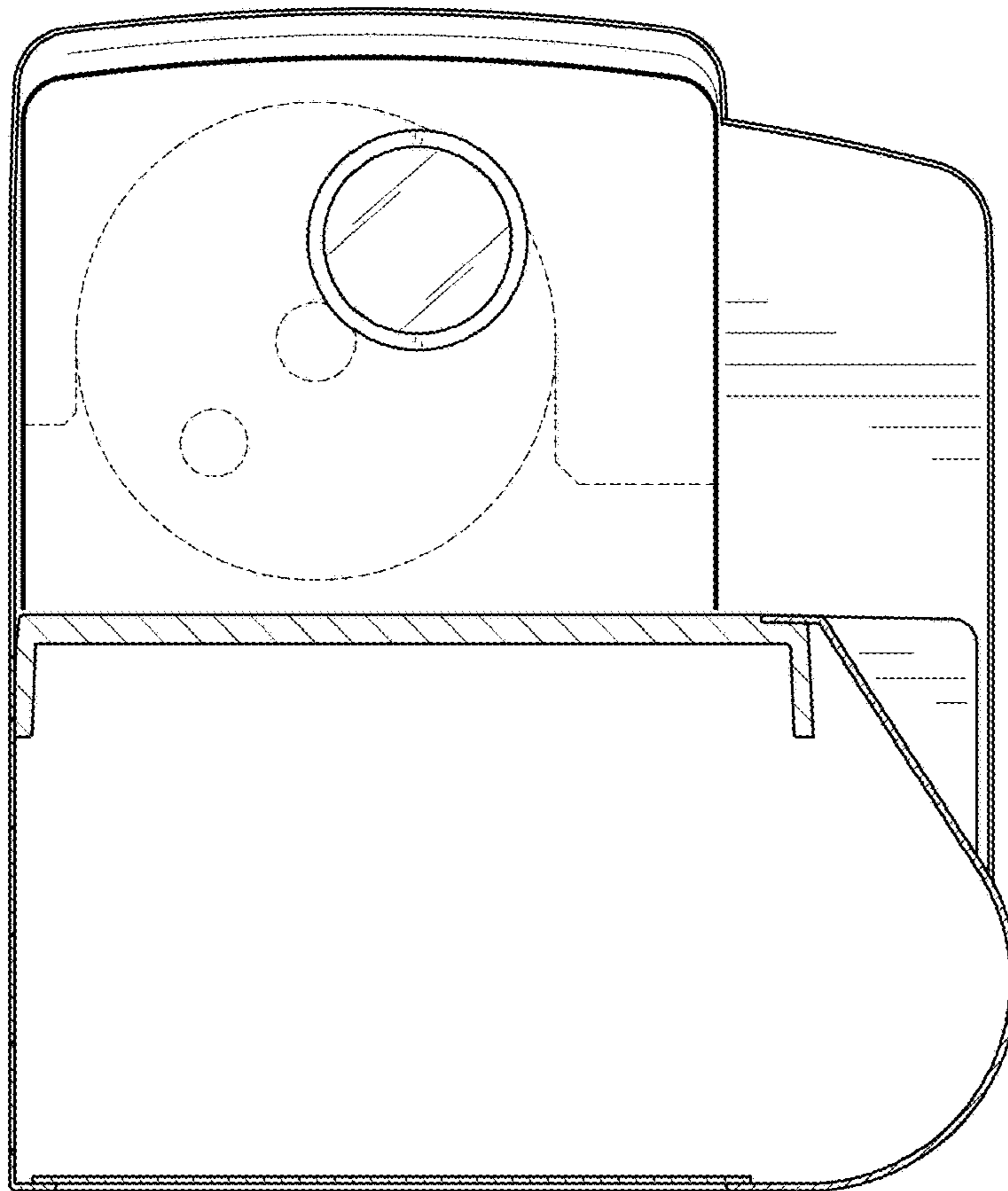


FIG. 9

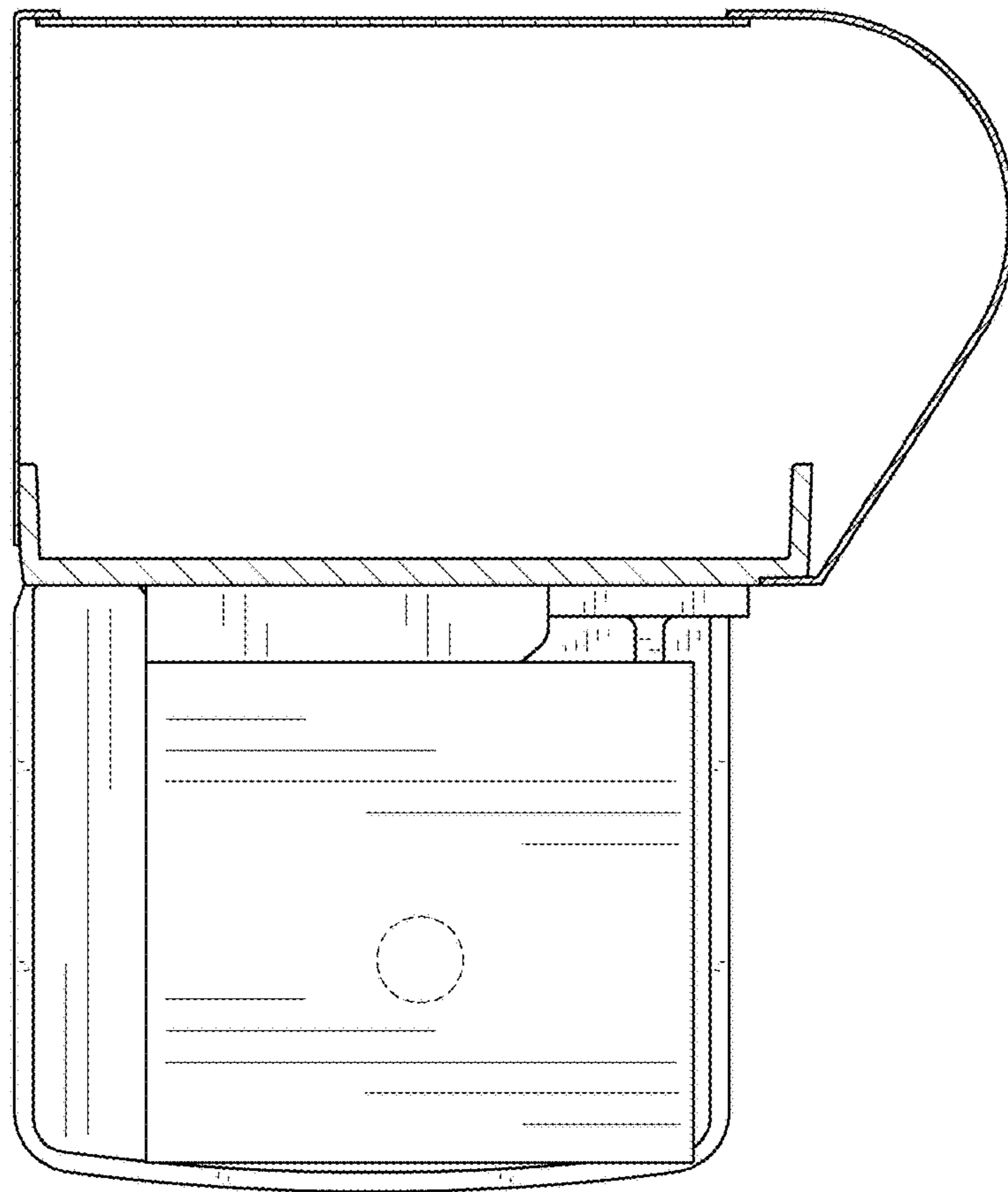


FIG. 10

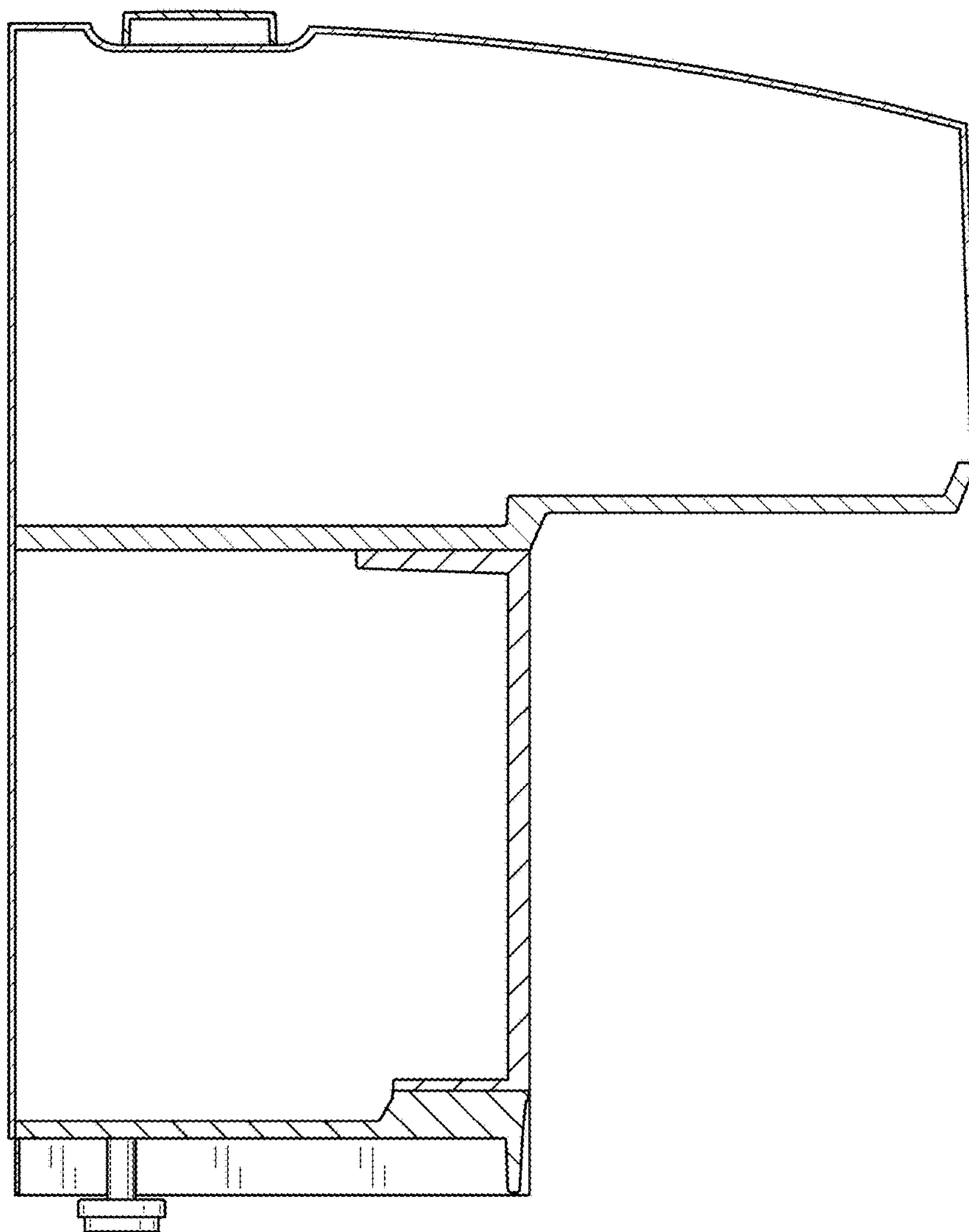


FIG. 11